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Characteristic			Symbol	Value	Unit		
Drain-Source Voltage			$V_{DSS}$	20	V		
Gate-Source Voltage			V <sub>GSS</sub>	±12	V		
Continuous Drain Current (Notes 6 & 9) V <sub>GS</sub> = 4.5V	Steady State	$T_C = +25$ °C $T_C = +70$ °C	I <sub>D</sub>	50 40	А		
		$T_A = +25$ °C $T_A = +70$ °C	I <sub>D</sub>	18 14	А		
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)			I <sub>DM</sub>	130	А		
Maximum Continuous Body Diode Forward Current (Note 6)			aximum Continuous Body Diode Forward Current (Note 6)		Is	2.6	А
Avalanche Current , L = 0.2mH			I <sub>AS</sub>	23.9	А		
Repetitive Avalanche Energy, L = 0.2mH			E <sub>AS</sub>	58.4	mJ		

## Thermal Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
Total Power Dissipation (Note 5)	T <sub>A</sub> = +25°C	P <sub>D</sub>	1.05	W	
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	$R_{ heta JA}$	120	°C/W	
Total Power Dissipation (Note 6)	T <sub>A</sub> = +25°C	P <sub>D</sub>	2.27	W	
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	$R_{ heta JA}$	55	9CAM	
Thermal Resistance, Junction to Case (Note 6)		$R_{ heta JC}$	4.2	• °C/W	
Operating and Storage Temperature Range		T <sub>J,</sub> T <sub>STG</sub>	-55 to +150	°C	

Notes:

- 5. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.
- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate.

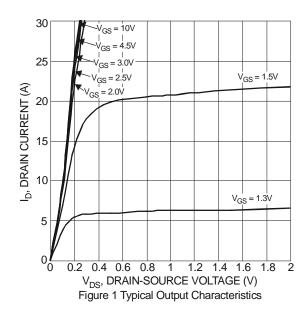


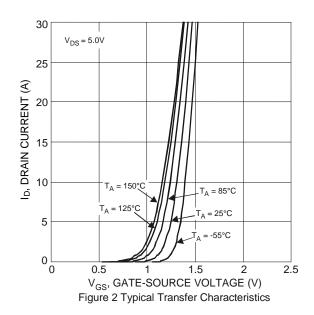
### Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	20	_	_	٧	$V_{GS} = 0V$ , $I_D = 250\mu A$	
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	I <sub>DSS</sub>	_	_	10	μA	$V_{DS} = 20V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 12V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	0.4	0.7	1.2	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$	
Static Drain-Source On-Resistance		_	4	4.6	0	$V_{GS} = 4.5V, I_D = 13.5A$	
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	_	4.9	8.7	mΩ	V <sub>GS</sub> = 2.5V, I <sub>D</sub> = 13.5A	
Diode Forward Voltage	$V_{SD}$	_	0.8	1.1	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = 27A	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C <sub>iss</sub>	_	6,495	_	pF		
Output Capacitance	Coss	_	546	_	pF	$V_{DS} = 10V, V_{GS} = 0V,$ f = 1MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>	_	477	_	pF	1 = 1101112	
Gate Resistance	Rg	_	0.7	_	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Total Gate Charge (V <sub>GS</sub> = 4.5V)	Qg	_	68.8	_	nC		
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	_	164	_	nC	10)/ 1 074	
Gate-Source Charge	Q <sub>gs</sub>	_	10.4	_	nC	$V_{DS} = 16V, I_D = 27A$	
Gate-Drain Charge	$Q_{gd}$	_	17.4	_	nC	1	
Turn-On Delay Time	t <sub>D(ON)</sub>		12.4	_	ns		
Turn-On Rise Time	t <sub>R</sub>	1	25.7	_	ns	$V_{GS} = 5V$ , $V_{DS} = 10V$ , $R_G = 4.7\Omega$ , $I_D = 13.5A$	
Turn-Off Delay Time	t <sub>D(OFF)</sub>	1	114	_	ns		
Turn-Off Fall Time	t <sub>F</sub>	_	38	_	ns		
Body Diode Reverse Recovery Time	t <sub>RR</sub>		16.1	_	ns	$I_F = 13.5A$ , $di/dt = 100A/\mu s$	
Body Diode Reverse Recovery Charge	Q <sub>RR</sub>		8.5	_	nC	$I_F = 13.5A$ , $di/dt = 100A/\mu s$	

Notes:

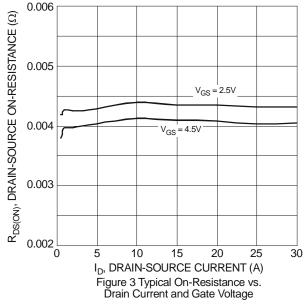
- 7. Short duration pulse test used to minimize self-heating effect. 8. Guaranteed by design. Not subject to product testing.
- 9. Limited by package.

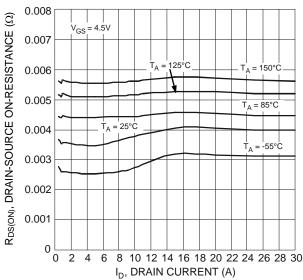


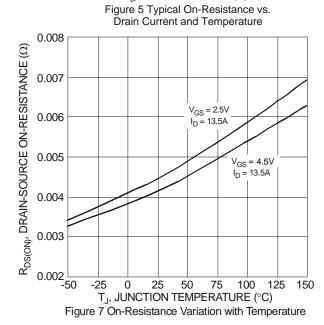


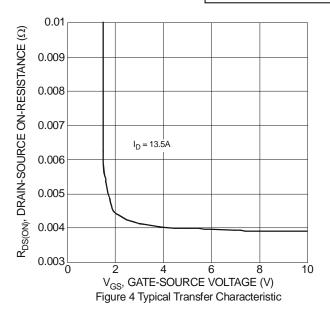












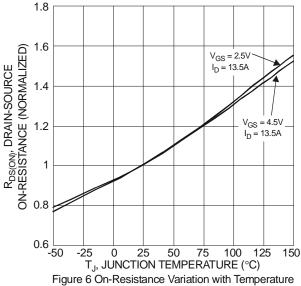
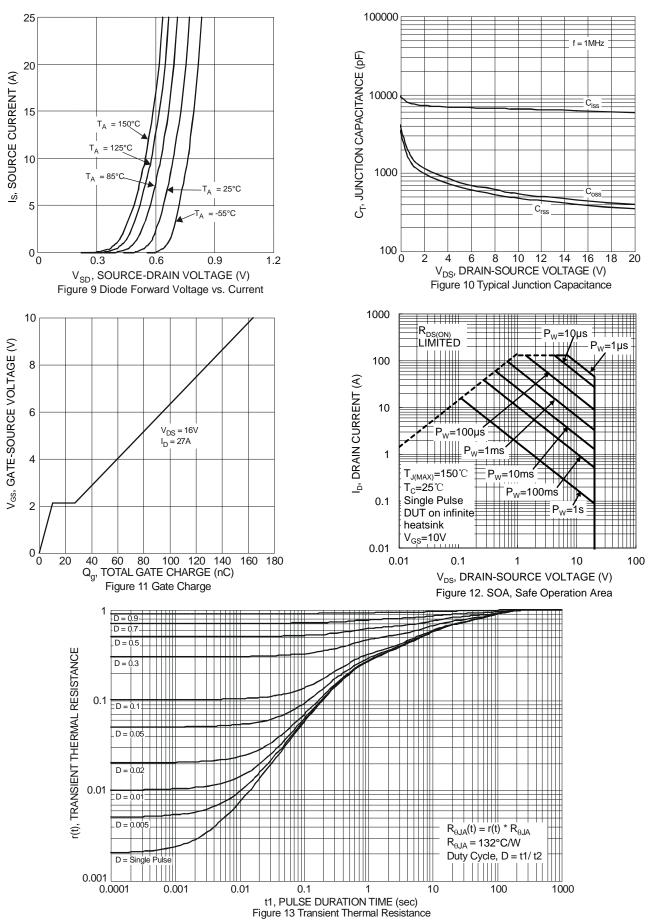


Figure 8 Gate Threshold Variation vs. Junction Temperature





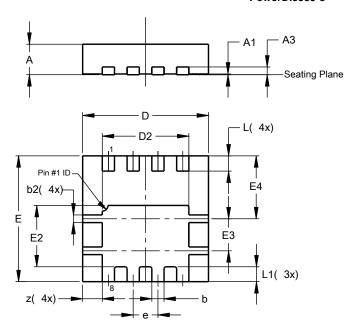




## **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### PowerDI3333-8

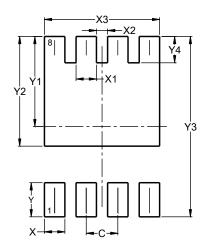


PowerDI3333-8						
Dim	Min	Max	Тур			
Α	0.75	0.85	0.80			
A1	0.00	0.05	0.02			
A3	-	-	0.203			
b	0.27	0.37	0.32			
b2	0.15	0.25	0.20			
D	3.25	3.35	3.30			
D2	2.22	2.32	2.27			
Е	3.25	3.35	3.30			
E2	1.56	1.66	1.61			
E3	0.79	0.89	0.84			
E4	1.60	1.70	1.65			
е	_	_	0.65			
L	0.35	0.45	0.40			
L1	_	_	0.39			
Z	_	_	0.515			
All Dimensions in mm						

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### PowerDI3333-8



Dimensions	Value (in mm)
C	0.650
Х	0.420
X1	0.420
X2	0.230
Х3	2.370
Υ	0.700
Y1	1.850
Y2	2.250
Y3	3.700
Υ4	0.540



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